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Response Under 37 C.F.R. §1.116
Expedited Procedure Examining
Examining Group 2621

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Edward W. Conrad, et al.

Examiner: Tom Y. Lu

Serial No.: 09/512,570

Art Unit: 2621

Filed: February 24, 2000

Docket: BUR919990152US1(12769)

For: METHOD FOR MEASUREMENT
OF FULL-TWO DIMENSIONAL
SUBMICRON SHAPES

Dated: September 22, 2003

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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AMENDMENT UNDER 37 C.F.R. §1.116

Dear Sir:

OFFICIAL

In response to the Office Action dated July 3, 2003, please amend the subject patent application as follows.

CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that this paper is being facsimile transmitted to the Patent and Trademark Office on the date shown below.

Dated: September 22, 2003

John S. Sensny
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